

Notice of References Cited

Application/Control No.

10/542,079

Applicant(s)/Patent Under

Reexamination

SAWADA, HIDEKI

Examiner

Cheukfan Lee

Art Unit

2625

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,184,513	02-2001	Sawada, Hideki	250/208.1
	B	US-			
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	E	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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